Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10580087	PECH ET AL.
Examiner	Art Unit
Kruer, Stefan	3654

SEARCHED					
Class	Subclass	Date	Examiner		
242	374, 379.1, 383.2	01/07/2008	SHK		
297	480				
280	806				
B60R	22/46				

Kruer, Stefan

SEARCH NOTES					
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PLUS	01/07/2008	SHK			

INTERFERENCE SEARCH				
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